

Data sheet acquired from Harris Semiconductor SCHS066C- Revised October 2003

CMOS 8-Bit Addressable Latch

High-Voltage Types (20-Volt Rating)

■ CD4099B 8-bit addressable latch is a serial-input, parallel-output storage register that can perform a variety of functions.

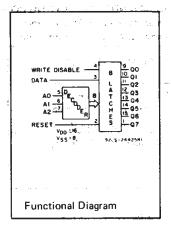
Data are inputted to a particular bit in the latch when that bit is addressed (by means of inputs A0, A1, A2) and when WRITE DISABLE is at a low level. When WRITE DISABLE is high, data entry is inhibited; however, all 8 outputs can be continuously read independent of WRITE DISABLE and address inputs.

A master RESET input is available, which resets all bits to a logic "0" level when RESET and WRITE DISABLE are at a high level. When RESET is at a high level, and WRITE DISABLE is at a low level, the latch acts as a 1-of-8 demultiplexer; the bit that is addressed has an active output which follows the data input; while all unaddressed bits are held to a logic "0" level.

The CD4099B types are supplied in 16-lead hermetic ceramic dual-in-line packages (F3A suffix), 16-lead plastic dual-in-line packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

Features:

- Serial data input Active parallel output
- Storage register capability Master clea
- Can function as demultiplexer
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V (full package-temperature range), 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) = 1 V at V_{DD} = 5 V, 2 V at V_{DD} = 10 V, 2.5 V at V_{DD} = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Séries CMOS Devices"



CD4099B Types

Applications:

- Multi-line decoders
- A/D converters

MAXIMUM RATINGS, Absolute-Maximum Values:	A BOOK STATE
DC SUPPLY-VOLTAGE RANGE, (VDD)	
Voltages referenced to VSS Terminal)	0.5V to +20V
INPUT VOLTAGE RANGE, ALL INPUTS	0.5V to V _{DD} +0.5V
DC INPUT CURRENT, ANY ONE INPUT	±10mA
POWER DISSIPATION PER PACKAGE (PD):	And the great state of the state of
For T _A = -55°C to +100°C	500mW
For T _A = -55°C to +100°C	Derate Linearity at 12mW/°C to 200mW
For TA = +100°C to +125°C	Derate Linearity at 12mW/°C to 200mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	ackage Types) 100mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR FOR TA = FULL PACKAGE-TEMPERATURE RANGE (AII P	ackage Types)
DEVICE DISSIPATION PER OUTPUT TRANSISTOR FOR TA = FULL PACKAGE-TEMPERATURE RANGE (AII P OPERATING-TEMPERATURE RANGE (TA)	ackage Types)

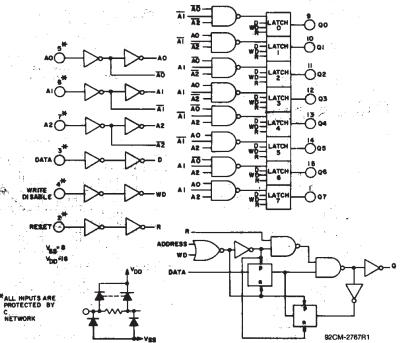
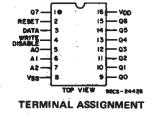


Fig. 1 — Logic diagram of CD4099B and detail of 1 of 8 latches.



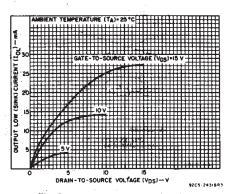


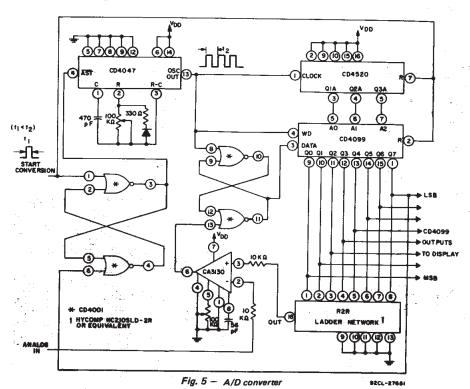
Fig. 2 — Typical output low (sink) current characteristics.

RECOMMENDED OPERATING CONDITIONS at $T_A = 25^{\circ}$ C (Unless otherwise specified) For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

CHARACTERISTIC	SEE	v_{DD}	LIN	UNITS	
	FIG. 15*	(V)	MIN.	MAX.	OWIS
Supply Voltage Range: (At T _A = Full Package Temperature Range)			3	18	V.
Minimum Pulse Width, tW		5	200	-	
Data	(4)	10	100	_	
		15	80		٠.
		5	400	_	
Address	(8)	10	200		ns
		15	125	<u> </u>	
		5	150	. –	
Reset	(5)	10	75	_	. ,
		15	50	-	
Setup Time, t _S		5	100	_	
Data to WRITE DISABLE	(6)	10	50	. –	
		15	35	_	ns
Hold Time, tH		5	150	_	
Data to WRITE DISABLE		10	75	· _	ns
		15	50	_	

^{*} Circled numbers refer to times indicated on master timing diagram.

Note: In addition to the above characteristics, a WRITE DISABLE ON time (the time that WRITE DISABLE is at a high level) must be observed during an address change for the total time that the external address lines AO, A1, and A2 are settling to a stable level, to prevent a wrong cell from being addressed (see Fig. 3).



MODE SELECTION									
WD	R	ADDRESSED LATCH	UNADDRESSED LATCH						
0	0	Follows Data	Holds Previous State						
0	1	Follows Data (Active High 8	Reset to "0" -Channel Demulti- plexer)						
1	0	Holds Pr	evious State						
1	1	Reset to "0"	Reset to "0"						

WD = WRITE DISABLE

R = RESET

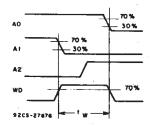


Fig. 3 - Definition of WRITE DISABLE ON time.

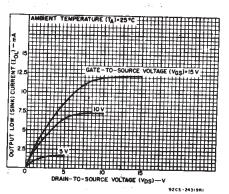


Fig. 4 — Minimum output low (sink) current characteristics.

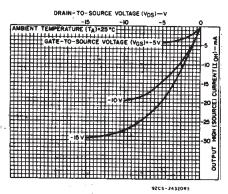
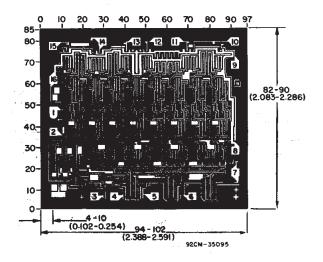


Fig. 6 - Typical output high (source) current characteristics.

STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	COND	ITION	IS	LIMIT	LIMITS AT INDICATED TEMPERATURES (°C)						
ISTIC	Vo.	VIN	v_{DD}			.05	.405	+25			UNITS
	(V)	(V)	(V)	-55	-40	+85	+125	Min.	Тур.	Max.	:
Quiescent Device		0,5	5	5	5	150	150	* -	0.04	5	
Current,	<u> </u>	0,10	10	10	10	300	300	_	0.04	10	μА
IDD Max.		0,15	15	20	20	600	600		0.04	20	μ
	-	0,20	20	100	100	3000	3000	-	0.08	100	
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1		_
(Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	- .	
IOL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3 4	6.8	_	
Output High	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	-	mA
(Source)	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2]
Current,	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	_	
IOH Min.	13.5	0,15	15	-4.2	4	-2.8	-2.4	-3.4	-6.8	-	
Output Voltage:	90 <u> </u>	0,5	5	0.05				-	0	0.05	
Low-Level,	-	0,10	10		0	.05		-	0	0.05	
VOL Max.	_	0,15	15		0	.05		-	0	0.05	_v
Output Voltage:	-	0,5	5		4	.95		4.95	5	-	ľ
High-Level,	-	0,10	10		9	.95		9.95	10.	-"	
VOH Min.	-	0,15	15		14	1.95		14.95	15	-	
Input Low	0.5, 4.5	-	5		1	1.5		_	_	1.5	
Voltage,	1, 9	_	10			3		_	_	3	
VIL Max.	1.5,13.5	_	15			4		_	_	4	
Input High	0.5, 4.5		5		3	3.5		3.5	_		٧
Voltage,	1, 9	-	10			7		7]
VIH Min.	1.5,13.5	-	15			11		11	_	_	
Input Current IIN Max.		0,18	18	±0.1	±0.1	,±1	±1	-	±10-5	±0,1	μА



CD4099BH DIMENSIONS AND PAD LAYOUT

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10⁻³ inch).

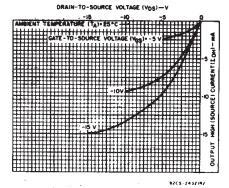


Fig.7 - Minimum output high (source) current characteristics.

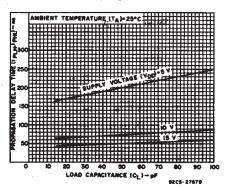


Fig. 8 — Typical propagation delay time (deta to Qn) vs. load capacitance.

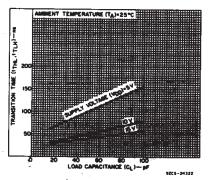


Fig. 9 — Typical transition time vs. load capacitance.

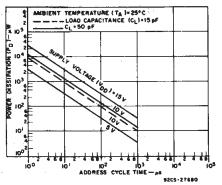


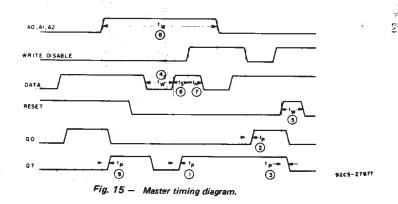
Fig. 10 — Typical dynamic power dissipation vs. address cycle time.

CD4099B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25° C, C_L = 50 pF, Input t_F , t_f = 20 ns, R_L = 200 K Ω

CHARACTERISTIC	CONDI SEE FIG.15*	V _{DD}	ALL PACI	UNITS	
Propagation Delay: tpLH,		5	200	MAX. 400	
^t PHL	1	10	75	150	·
Data to Output,		15	50	100	
WRITE DISABLE	 	5	200	400	
to Output, tpLH,	(2)	10	80	160	ns
t _{PHL}		15	60	120	
		5	175	350	
Reset to Output,	3	10	80	160	
^t PHL		15	65	130	
Address to Output,		5	225	450	
tPLH,	9	10	100	200	
t _{PHL}		15	75	150	
Transition Time, t _{THL} ,		5	100	200	· .
(Any Output) t _{TLH}		10	50	100	ns
		15	40	80	
Minimum Pulse		5	100	200	
Width, t _W	4	10	50	100	ns
Data		15	40	. 80	
		5	200	400	··· <u>·</u>
Address	8	10	100	200	ns
		15	65	125	
		5	75	150	
Reset	5	10	40	75	ns
		15	25	50	
Minimum Setup		5	50	100	
Time, tg	6	10	25	50	ns
Data to WRITE DISABLE		15	20	35	
Minimum Hold		5	75	150	
Time, t _H	0 [10	40	75	ns
Data to WRITE DISABLE		15	25	50	
Input Capacitance, CIN	Any Inp	out	5	7.5	pF

^{*}Circled numbers refer to times indicated on master timing diagram.



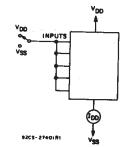


Fig. 11 — Quiescent device current test circuit.

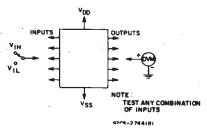


Fig. 12 - Input voltage test circuit.

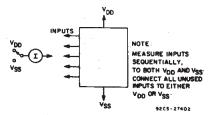


Fig. 13 - Input current test circuit.

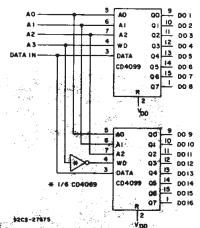


Fig. 14 - 1 of 16 decoder/demuttelexer.

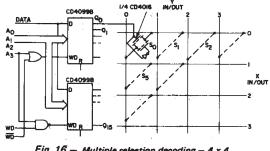


Fig. 16 — Multiple selection decoding — 4 x 4 crosspoint switch.





4-Feb-2021

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD4099BE	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4099BE	Samples
CD4099BF	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4099BF	Samples
CD4099BF3A	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4099BF3A	Samples
CD4099BM	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4099BM	Samples
CD4099BM96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4099BM	Samples
CD4099BMG4	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4099BM	Samples
CD4099BNSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4099B	Samples
CD4099BPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM099B	Samples
JM38510/17601BEA	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 17601BEA	Samples
M38510/17601BEA	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 17601BEA	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



PACKAGE OPTION ADDENDUM

4-Feb-2021

- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD4099B, CD4099B-MIL:

Catalog: CD4099B

Military: CD4099B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

All difficulties are florifical												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4099BM96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD4099BNSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4099BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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*All dimensions are nominal

Device	Package Type	Type Package Drawing		SPQ	Length (mm)	Width (mm)	Height (mm)
CD4099BM96	SOIC	D	16	2500	333.2	345.9	28.6
CD4099BNSR	SO	NS	16	2000	853.0	449.0	35.0
CD4099BPWR	TSSOP	PW	16	2000	853.0	449.0	35.0

14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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